INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 713-1004		U.S. PATENT APPLICATION NO.				
				APPLICANT Christian BAUER						
				FILING DATE January 30, 2004	GROUP					
	 	U.S. PATENT	DOG				4 2	Citations Grant		
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME		CLASS	SUBCLASS	FIL			
	·									
						ļ <u> </u>	<u> </u>			
						<u> </u>				
 						 	-			
	·····				•					
						†	-			
								-		
		FOREIGN PATEN	NOT T	OCUMENTS		<u> </u>	<u> </u>	2.5.5		
EXAMINER'S	PATENT NO.	DATE			CLASS	Cupo: Acc	Abst			
INITIALS	4034545 A1	05-1992		rmany	CLASS	SUBCLASS	Yes	No		
ATW	0483636 B1	12-1992		urope	3	13	X			
11,1~					3	00	<u> </u>			
	<u> </u>					 	<u> </u>			
						,				
	ОТНЕ	R ART (Including Author,	Title	e, Date, Pertinent	Pages, Et	c.) :		15 Apr.		
										
								•		
		-								
EXAMINER	0 1 1 1 1	mh .	DA	TE CONSIDERED						
<u> </u>	or lest my	-VN) 2/7/01	<u>†</u>					

EXAMINER: Initial if deference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. 713-1004 U.S. PATENT APPLICATION NO. 10/767,744				
				APPLICANT Christian BAUER				
JUN 3 0 2004 \$ (PTO-1449) U.S. PATENT D EXAMINER'S				FILING DATE January 30, 2004	,	GROUP 3632		
FRADENIS		U.S. PAT	TENT DO	CUMENTS				
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME		CLASS	SUBCLASS	FILING DATE	
ATH	5,460,342	10/1995	Dore et al					
AIN	6,073,891	6/2000	Humber					
					ļ.			
					<u> </u>	ļ		
		·			 			
					 			
					 			
							,	
				•				
				-				
		FOREIGN I	PATENT	DOCUMENTS				
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Translation Yes No	
AIN	36 02 625	3/1987		DE	3	o8	\times	
AN	198 10 834	9/1998		DE	11	84	λ	
AIN	198 57 853	6/2000		DE	3	22	X	
#TIN	296 20 300	3/1997		DE	3	22	×	
AJN	0 838 626	4/1998		EP	55	33	×	
ATU	1 036 966	9/2000		EP	3	10	24	
AJN	02/065009	8/2002		WIPO	3	553	×	
	OTHE	R ART (Including A	uthor, Tit	le, Date, Pertinent	Pages, Et	e.)		
-	· · · · · · · · · · · · · · · · · · ·		_					
EXAMINER	A. Joseph W.	LDA	D/	ATE CONSIDEREI) +			

EXAMINER: Initial if reffrence considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

INFORMATION DISCLOSURE OLD CITATION IN AN				ATTY. DOCKET NO. 713-1004		U.S. PATENT APPLICATION NO. 10/767,744				
10	APPLICATION (PTO-1449)			APPLICANT Christian BAUER						
				FILING DATE January 30, 2004	GROUP 3632					
PRADEMANKO		U.S. PATEN	T DC	CUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME		CLASS	SUBCLASS		ING ATE		
					<u> </u>					
										
			<u></u>							
<u> </u>		FOREIGN PAT	ENT	DOCUMENTS		<u> </u>				
EXAMINER'S	PATENT NO.	DATE		COUNTRY	CLASS	SUBCLASS		lation		
AJV	GB2129863	5/1984	GB		Z	22	Yes	× ×		
AN	EP0666428	8/1995		ЕР	37	08		×		
			<u></u>							
	OTHE	R ART (Including Autho	or Ti	tle Date Portinent	Pages Et					
	UTHER	AKI (including Autho	ur, II	ue, Date, Pertinent	rages, Etc	.,				
				·						
EXAMINER 12/7	to A. Jan	Wit	D.	ATE CONSIDERED ノンノフトッソ)					

EXAMINER! Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.